If AFTER the later date of the first with Rule 97(E) Certificate or Fee				Atty. Docket No. 83489DMW Customer No. 01333 Applicant: Shoupu Chen, et al				
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)			Filing Date 26 November 2001			Group		
		U.	S. PA	TENT DOCUMENTS	_			
Examiner Initial *	DOCUMENT NUMBER	DATE		NAME	CLASS	SUBCLA	ISS FILING DATE IF APPROPRIATE	
as	USSN 09/740,562		Sho	oupu Chen et al.			12/19/00	
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		FOR	EIGN	PATENT DOCUMENTS				
Examiner Initial*	DOCUMENT NUMBER	DATE		COUNTRY	CLASS	SUBCLA	ASS <u>TRANSLATION</u> YES NO	
				Author, Title, Date, Pertinent Pages				
CK	"Distance to an Elli Press, Boston, MA,	-	Har	t. Graphics Gems IV, Pa	aul S. He	eckber	t, Editor, Academic	
W	"Active shape ModelsTheir Training and Application" by T.F. Cootes, C.J. Taylor, D.H. Cooper, and J. Graham. Computer Vision and Image Understanding, Vol. 61, No. 1, pp. 38-59, 1995.							
EXAMINER	DATE CONSIDERED 9/7/04							

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		U.	S. PAT	ENT DOCUMENTS				
Examiner Initial*	DOCUMENT NUMBER	DATE		NAME	CLASS	SUBCLA	SS	FILING DATE IF APPROPRIATE
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E	DOCUMENT NUMBER	DATE		COUNTRY	22.455	SURCLA	22	TRANSI ATION

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Examiner Initial*	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
oc	0 899 680 A	3/3/31999	EP			
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W	1 229 493 A	8/7/2002	EP	-4		

Saber E. et al., "Face Detection and Facial Feature Extraction Using Color, Shape and Symmetry-based Cost Functions" Proceedings of the International Conference on Pattern Recognition, XX, XX, Vol. 3, 1996, pages 654-658, XP000863534 paragraph '0002.

Chow G. et al., "Towards a System for Automatic Facial Feature Detection" Pattern Recognition, Pergamon Press Inc. Elmsford, NY, US, Vol. 26, No. 12, 1 December 1993 (1993-12-01), pages 1739-1755, XP000420368; ISSN: 0031-3208, paragraph '03.1 - paragraph '03.2.

EXAMINER A	DATE CONSIDERED 9/7104							
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								

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